



Contribution ID: 49

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## **Diagnostics in the time domain (EO, streaking, etc.) - Chairs: Bernd Steffen and Serge Bielawski**

*Thursday 30 June 2022 10:30 (2 hours)*

Including, but not limited to:

\* Laser-based diagnostics:

- Electro-optic detection of electric fields
- X-ray-induced transient reflectivity,
- optical transposition
- etc.

\* Diagnostics based on electron bunch deflection:

- RF-based transverse cavities
- THz electric field-induced deflection (split-ring resonators, etc.)
- etc.

Location to be decided:

- CERLA
- or P5-bis building, Room 172 (1st floor)
- or P5-bis building, Salle du conseil room (2nd floor)

**Presenters:** STEFFEN, Bernd; Prof. BIELAWSKI, Serge

**Session Classification:** Working groups